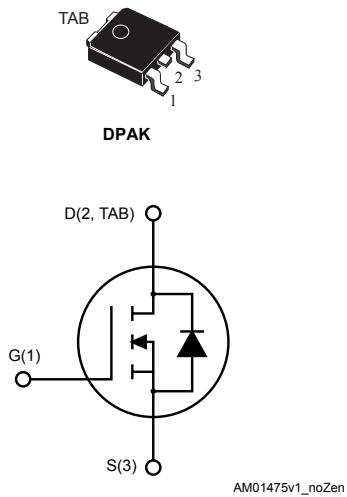


## Automotive-grade N-channel 250 V, 318 mΩ, 8 A, STripFET™ II Power MOSFET in a DPAK package

### Features



Order code	V <sub>DS</sub>	R <sub>DS(on)max.</sub>	I <sub>D</sub>
STD8NF25	250 V	420 mΩ	8 A

- AEC-Q101 qualified 
- 100% avalanche tested
- 175 °C maximum junction temperature

### Applications

- Switching applications

### Description

This Power MOSFET series has been developed using STMicroelectronics' unique STripFET™ process, which is specifically designed to minimize input capacitance and gate charge. This renders the device suitable for use as primary switch in advanced high-efficiency isolated DC-DC converters for telecom and computer applications, and applications with low gate charge driving requirements.

Product status link	
<a href="#">STD8NF25</a>	
Product summary	
<b>Order code</b>	
Order code	STD8NF25
Marking	8NF25
Package	DPAK
Packing	Tape and reel

## 1 Electrical ratings

**Table 1.** Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	250	V
$V_{GS}$	Gate-source voltage	$\pm 20$	V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	8	A
	Drain current (continuous) at $T_C = 100^\circ\text{C}$	6	A
$I_{DM}^{(1)}$	Drain current (pulsed)	32	A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	72	W
$T_J$	Operating junction temperature range	-55 to 175	$^\circ\text{C}$
$T_{stg}$	Storage temperature range		

1. Pulse width is limited by safe operating area.

**Table 2.** Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case	2.08	$^\circ\text{C/W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb	50	$^\circ\text{C/W}$

1. When mounted on an 1-inch<sup>2</sup> FR-4, 2 Oz copper board

**Table 3.** Avalanche characteristics

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or non-repetitive (pulse width limited by $T_{jmax}$ )	8	A
$E_{AS}$	Single pulse avalanche energy (starting $T_J = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{ V}$ )	110	mJ

**2****Electrical characteristics**(T<sub>CASE</sub> = 25 °C unless otherwise specified)**Table 4. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	250			V
I <sub>DSS</sub>	Zero gate voltage drain current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 250 V			1	µA
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 250 V, T <sub>C</sub> = 125 °C <sup>(1)</sup>			50	µA
I <sub>GSS</sub>	Gate body leakage current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V			±100	nA
V <sub>G(th)</sub>	Gate threshold voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 µA	2		4	V
R <sub>D(on)</sub>	Static drain-source on-resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8 A		318	420	mΩ

1. Defined by design, not subject to production test.

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C <sub>iss</sub>	Input capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz, V <sub>GS</sub> = 0 V	-	500	-	pF
C <sub>oss</sub>	Output capacitance			90		
C <sub>rss</sub>	Reverse transfer capacitance			15		
Q <sub>g</sub>	Total gate charge	V <sub>DD</sub> = 200 V, I <sub>D</sub> = 8 A, V <sub>GS</sub> = 0 to 10 V (see Figure 13. Test circuit for gate charge behavior)	-	16	-	nC
Q <sub>gs</sub>	Gate-source charge			3.5		
Q <sub>gd</sub>	Gate-drain charge			8		

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	V <sub>DD</sub> = 125 V, I <sub>D</sub> = 4 A, R <sub>G</sub> = 4.7 Ω, V <sub>GS</sub> = 10 V (see Figure 12. Test circuit for resistive load switching times and Figure 17. Switching time waveform)	-	13	-	ns
t <sub>r</sub>	Rise time			10		
t <sub>d(off)</sub>	Turn-off delay time			26		
t <sub>f</sub>	Fall time			6		

**Table 7. Source drain diode**

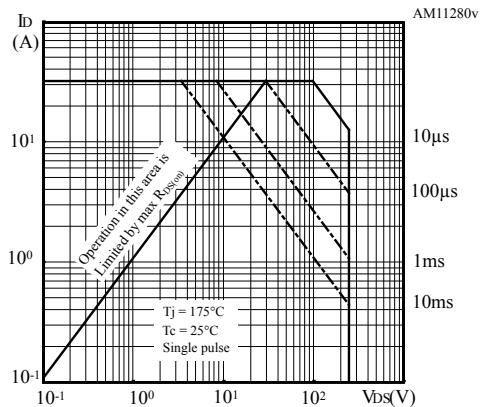
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I <sub>SD</sub>	Source-drain current	I <sub>SD</sub> = 8 A, V <sub>GS</sub> = 0 V	-	8	32	A
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)					
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 8 A, V <sub>GS</sub> = 0 V	-		1.5	V

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{rr}$	Reverse recovery time	$I_{SD} = 8 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ , $V_{DD} = 50 \text{ V}$ (see Figure 14. Test circuit for inductive load switching and diode recovery times)	-	115	8.5	ns
$Q_{rr}$	Reverse recovery charge			0.47		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current					A
$t_{rr}$	Reverse recovery time	$I_{SD} = 8 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ , $V_{DD} = 50 \text{ V}$ , $T_j = 150^\circ\text{C}$ (see Figure 14. Test circuit for inductive load switching and diode recovery times)	-	130	9.5	ns
$Q_{rr}$	Reverse recovery charge			0.58		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current					A

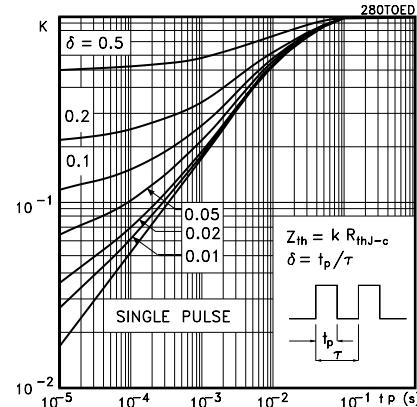
1. Pulse width limited by safe operating area.
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

## 2.1 Electrical characteristics (curves)

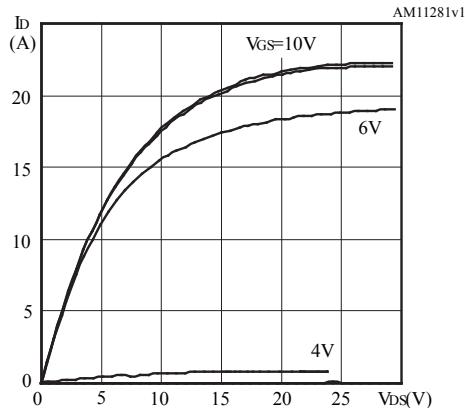
**Figure 1. Safe operating area**



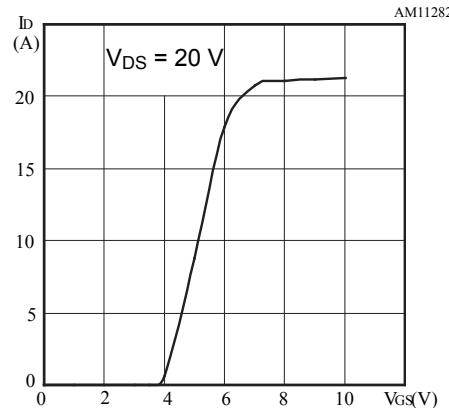
**Figure 2. Thermal impedance**



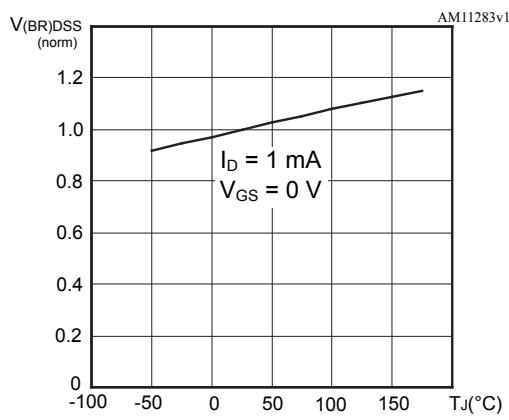
**Figure 3. Output characteristics**



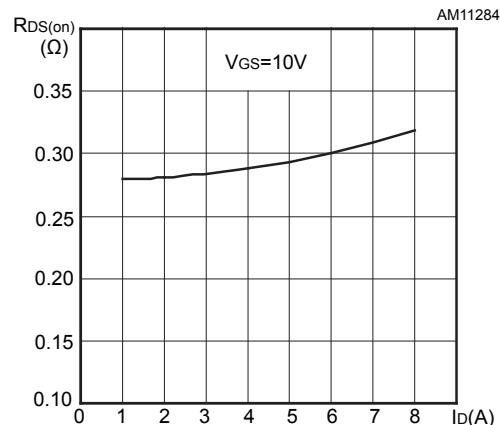
**Figure 4. Transfer characteristics**

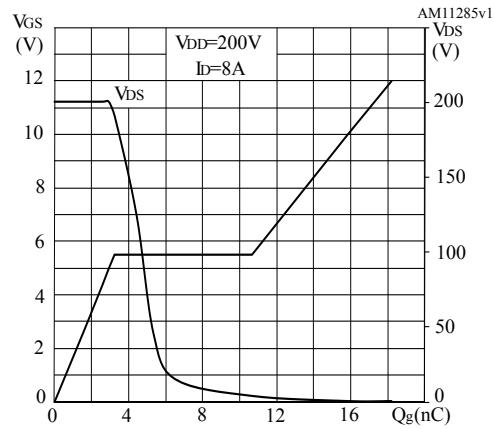
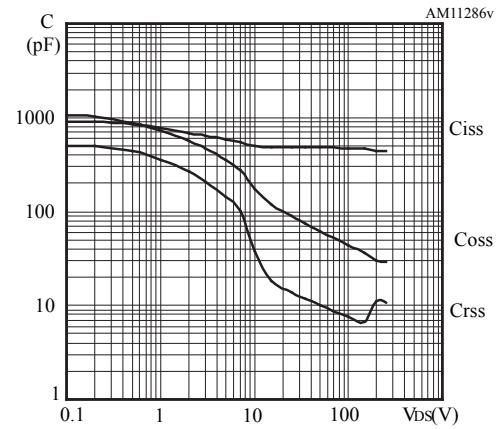
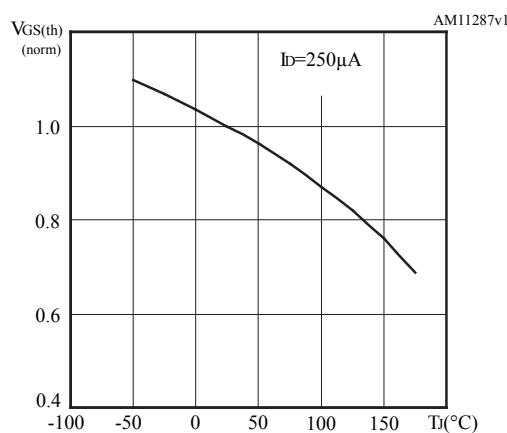
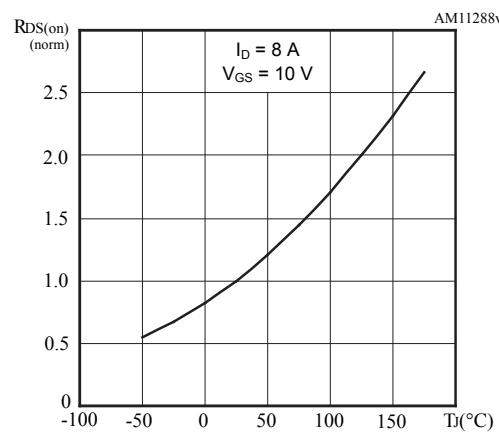
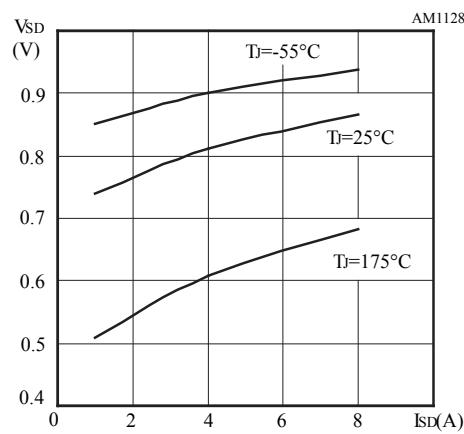


**Figure 5. Normalized V(BR)DSS vs temperature**



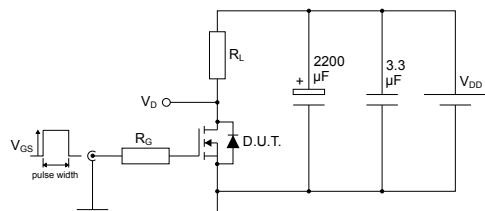
**Figure 6. Static drain-source on-resistance**



**Figure 7. Gate charge vs gate-source voltage**

**Figure 8. Capacitance variations**

**Figure 9. Normalized gate threshold voltage vs temperature**

**Figure 10. Normalized on-resistance vs temperature**

**Figure 11. Source-drain diode forward characteristics**


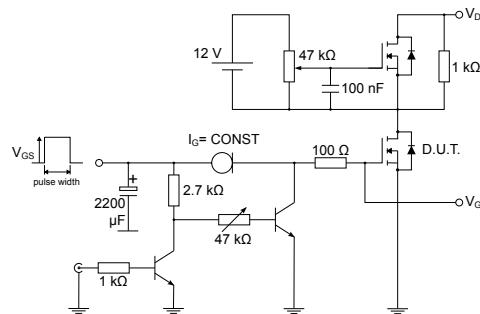
### 3 Test circuits

**Figure 12.** Test circuit for resistive load switching times



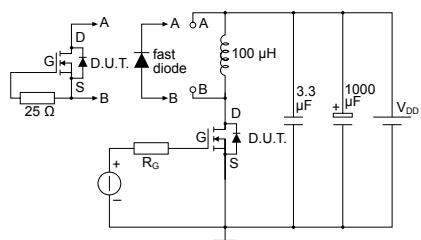
AM01468v1

**Figure 13.** Test circuit for gate charge behavior



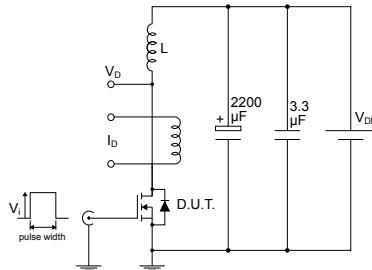
AM01469v1

**Figure 14.** Test circuit for inductive load switching and diode recovery times



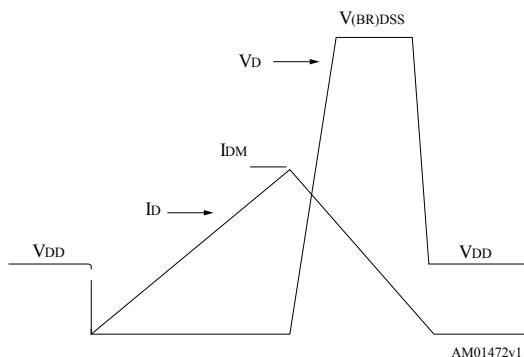
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**Figure 15.** Unclamped inductive load test circuit



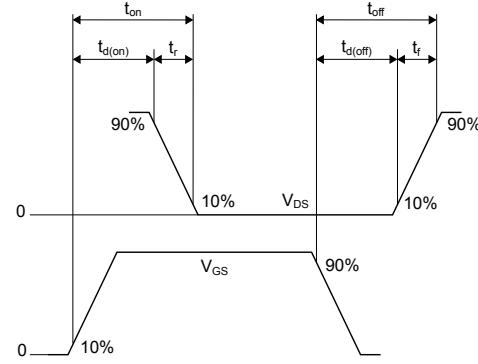
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**Figure 16.** Unclamped inductive waveform



AM01472v1

**Figure 17.** Switching time waveform



AM01473v1

**4**

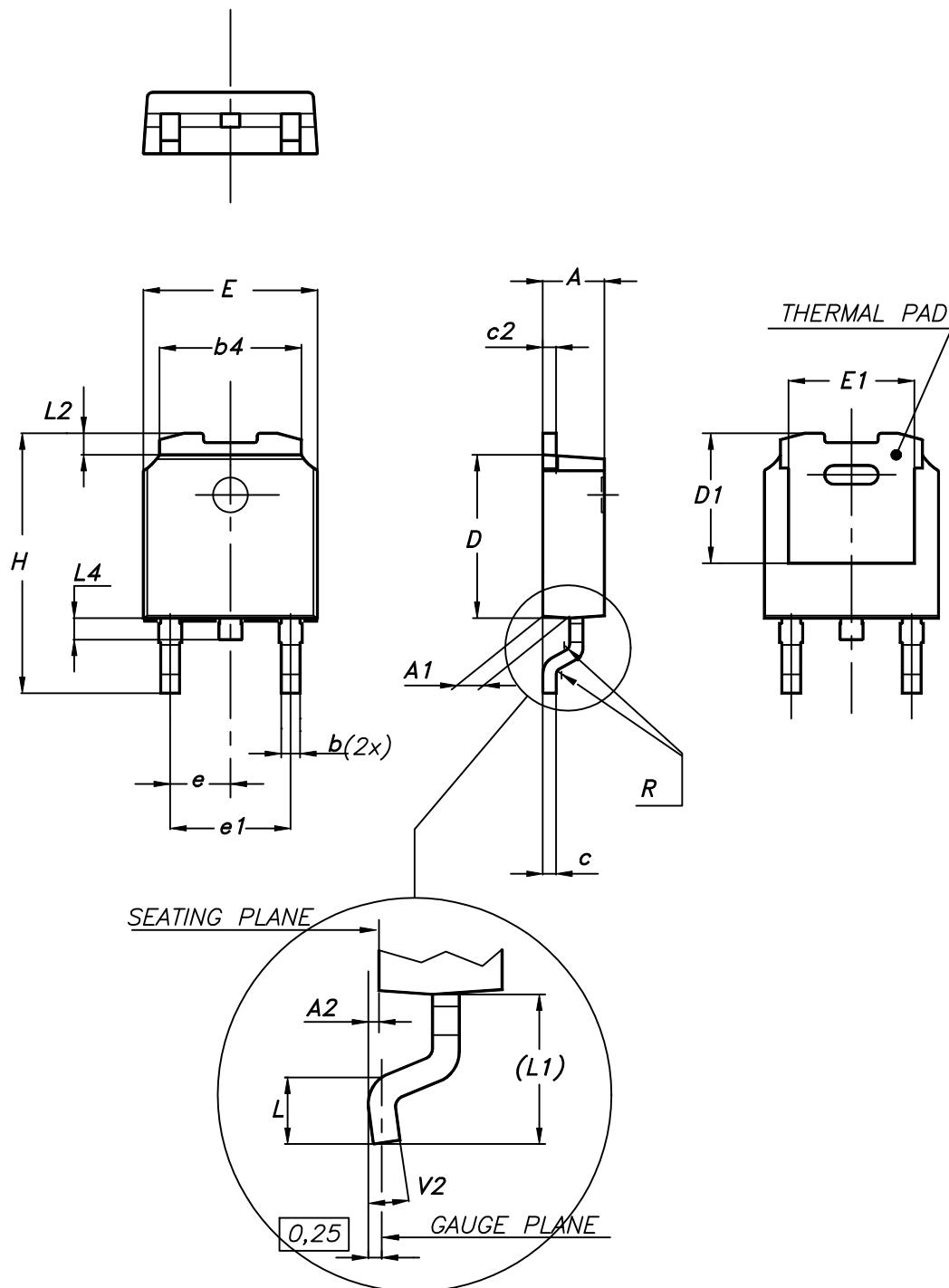
## Package information

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In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

## 4.1 DPAK (TO-252) type A2 package information

Figure 18. DPAK (TO-252) type A2 package outline

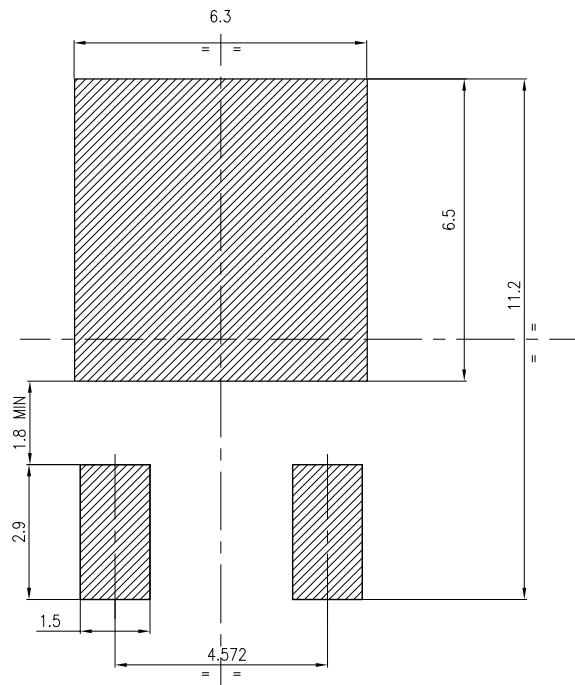


0068772\_type-A2\_rev25

**Table 8. DPAK (TO-252) type A2 mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1	4.95	5.10	5.25
E	6.40		6.60
E1	5.10	5.20	5.30
e	2.159	2.286	2.413
e1	4.445	4.572	4.699
H	9.35		10.10
L	1.00		1.50
L1	2.60	2.80	3.00
L2	0.65	0.80	0.95
L4	0.60		1.00
R		0.20	
V2	0°		8°

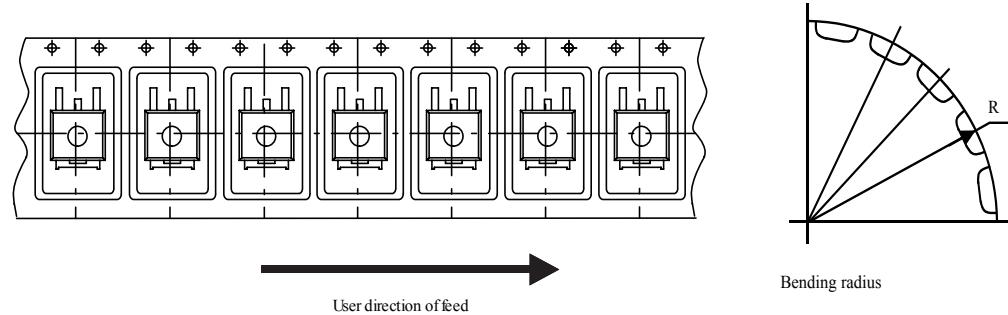
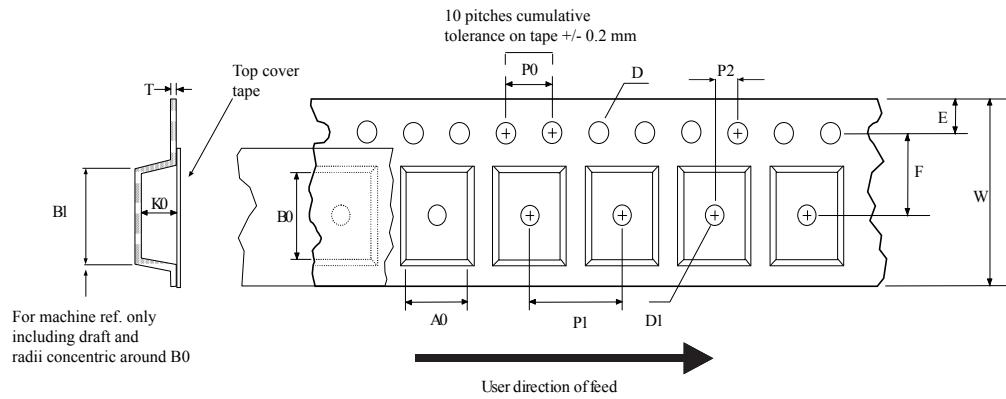
Figure 19. DPAK (TO-252) recommended footprint (dimensions are in mm)



FP\_0068772\_25

## 4.2 DPAK (TO-252) packing information

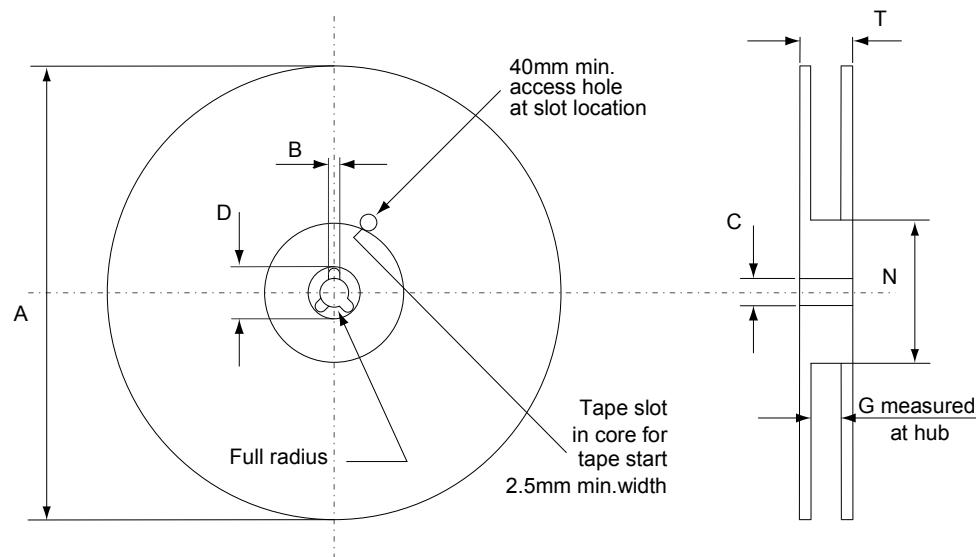
**Figure 20. DPAK (TO-252) tape outline**



Bending radius

AM08852v1

Figure 21. DPAK (TO-252) reel outline



AM06038v1

Table 9. DPAK (TO-252) tape and reel mechanical data

Tape			Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.		Min.	Max.
A0	6.8	7	A		330
B0	10.4	10.6	B	1.5	
B1		12.1	C	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
E	1.65	1.85	N	50	
F	7.4	7.6	T		22.4
K0	2.55	2.75			
P0	3.9	4.1	Base qty.		2500
P1	7.9	8.1	Bulk qty.		2500
P2	1.9	2.1			
R	40				
T	0.25	0.35			
W	15.7	16.3			

## Revision history

**Table 10. Document revision history**

Date	Version	Changes
26-Apr-2012	1	First release.
03-Jul-2018	2	Removed maturity status indication from cover page. Updated title, features and description on cover page. Updated <a href="#">Section 4.1 DPAK (TO-252) type A2 package information</a> . Minor text changes

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